Wuxi Unigroup Microelectronics CO.,LTD.

30V N-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low $R_{DS(ON)}$
- Low Gate Charge
- Optimized for fast-switching applications
- Qualified for industrial applications according to the relevant tests of JESD47

●Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

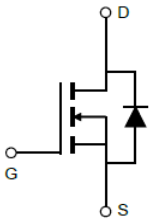
Product Summary

V_{DS}	30V
I_D (at V_{GS}=10V)	120A
$R_{DS(ON)}$ (at V_{GS}=10V)	< 3.4mΩ
$R_{DS(ON)}$ (at V_{GS}=4.5V)	< 4.7mΩ

100% UIS Tested

RoHS

TO-252



Part Number	Package Type	Form	Marking
TTD120N03AT	TO-252	Tape & Reel	120N03AT

Absolute Maximum Ratings (T_A =25ºC unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current [B]	T_C =25ºC	I_D	46	A
	T_C =100ºC		46	
Pulsed Drain Current [A]		I_{DM}	360	A
Avalanche Current [A]		I_{AS}	40	A
Single Pulse Avalanche Energy L =0.3mH [A]		E_{AS}	240	mJ
Power Dissipation [C]	T_C =25ºC	P_D	79	W
	T_C =100ºC		39	W
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 175	ºC

Thermal Characteristics

Parameter		Symbol	Maximum	Units
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.9	ºC/W
Maximum Junction-to-Ambient	Steady-State	$R_{\theta JA}$	100	

Electrical Characteristics(T_J =25ºC unless otherwise noted)

Symbol	Parameter	Conditions		Value			Units
				Min	Typ	Max	
STATIC PARAMETERS							
BV_{DSS}	Drain-Source Breakdown Voltage	I_D =250μA,V_{GS} =0V		30			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V	T_J =25ºC			1	μA
			T_J =125ºC			100	
I_{GSS}	Gate-Body Leakage Current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} =V_{GS}, I_D =250μA		1	1.6	2.4	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =30A			2.6	3.4	mΩ
		V_{GS} =4.5V, I_D =30A			3.6	4.7	mΩ
g_{FS}	Forward Transconductance	V_{DS} =5V, I_D =20A			30		S
V_{SD}	Diode Forward Voltage	I_S =30A, V_{GS} =0V				1	V
I_S	Maximum Body-Diode Continuous Current [B]					46	A
DYNAMIC PARAMETERS							
C_{iss}	Input Capacitance	V_{GS} =0V, V_{DS} =15V, f =1MH_Z			5027		pF
C_{oss}	Output Capacitance				549		
C_{rss}	Reverse Transfer Capacitance				510		
R_g	Gate Resistance	f =1MH_Z			1		Ω
SWITCHING PARAMETERS							
Q_g	Total Gate Charge	V_{GS} =10V,V_{DS} =15V, I_D =50A			120		nC
Q_{gs}	Gate Source Charge				18		
Q_{gd}	Gate Drain Charge				22		
$t_{D(on)}$	Turn-On Delay Time	V_{GS} =10V,V_{DS} =15V, I_D =50A, R_G =3Ω			14		ns
t_r	Turn-On Rise Time				20		
$t_{D(off)}$	Turn-Off Delay Time				52		
t_f	Turn-Off Fall Time				16		
t_{rr}	Body Diode Reverse Recovery Time	I_F =30A, di/dt =100A/μs			60		ns
Q_{rr}	Body Diode Reverse Recovery Charge				120		nC

A. Single pulse width limited by maximum junction temperature.

B. The maximum current rating is package limited.

C. The power dissipation P_D is based on $T_{J(MAX)}$ =175ºC, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

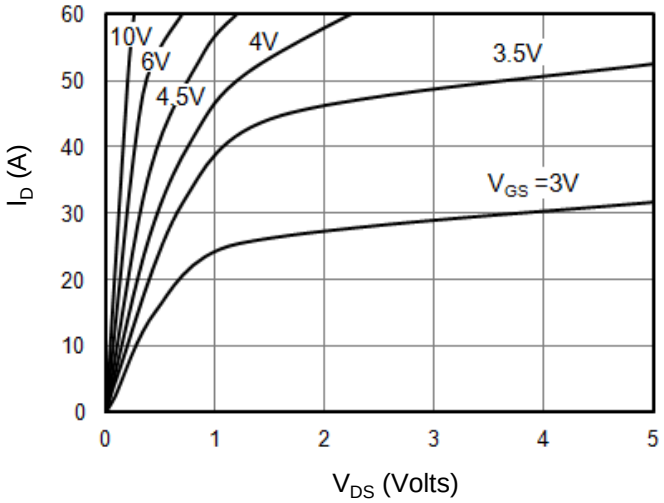


Figure 1: On-Region Characteristics

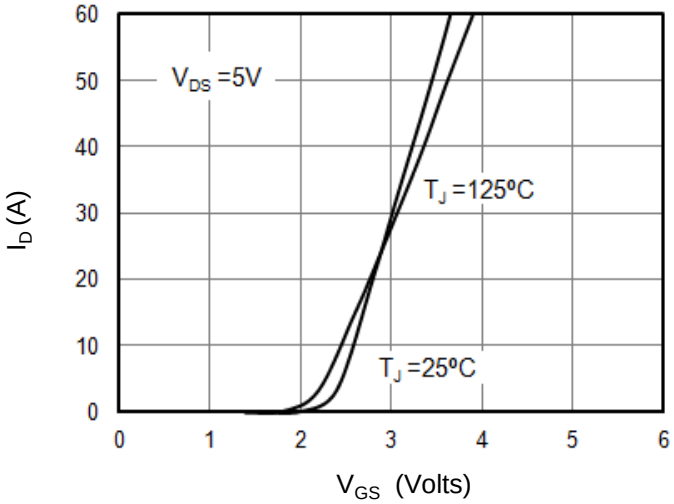


Figure 2: Transfer Characteristics

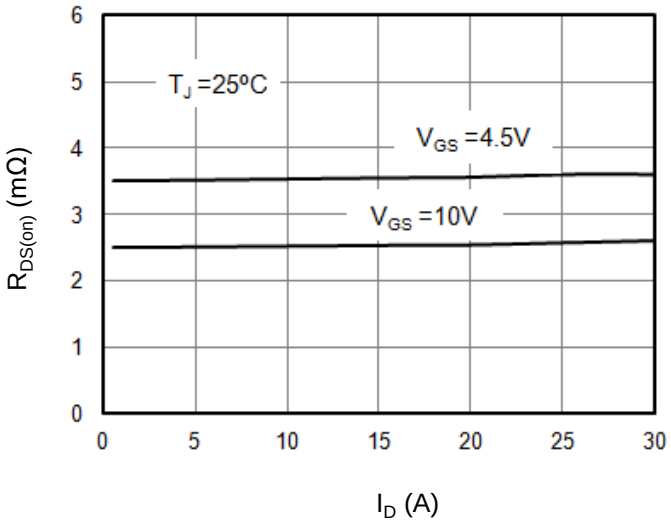


Figure 3: On-Resistance vs. Drain Current

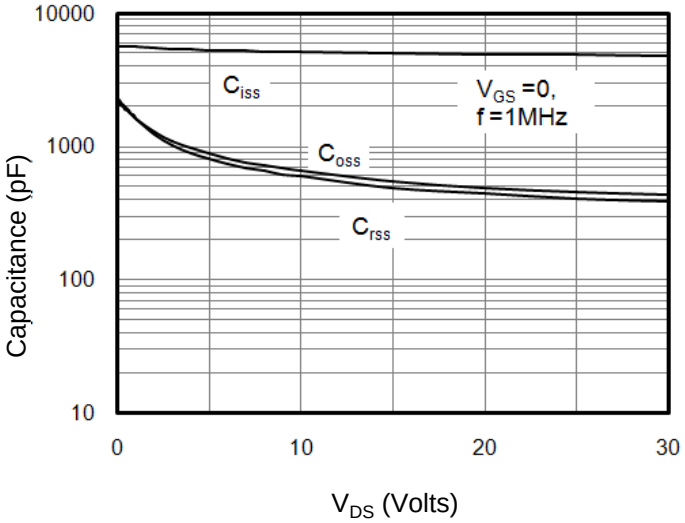


Figure 4: Capacitance Characteristics

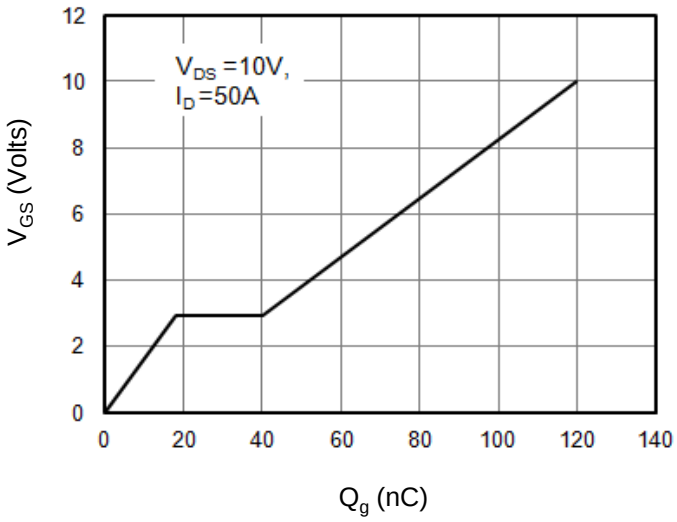


Figure 5: Gate Charge Characteristics

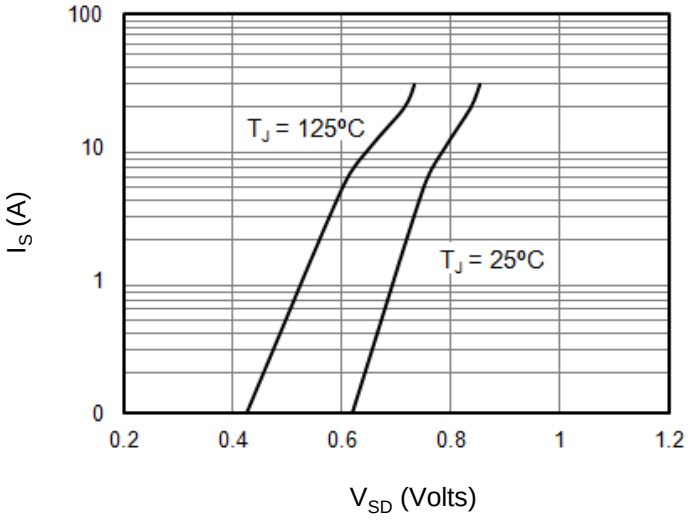


Figure 6: Body Diode Forward Voltage

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

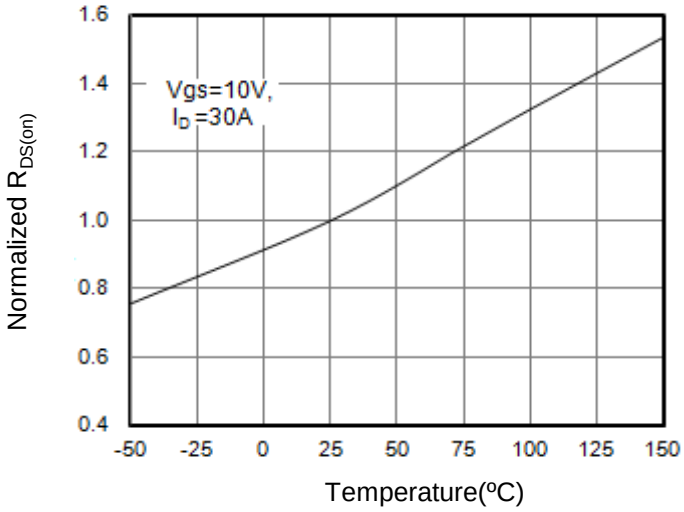


Figure 7: On-Resistance vs. Junction Temperature

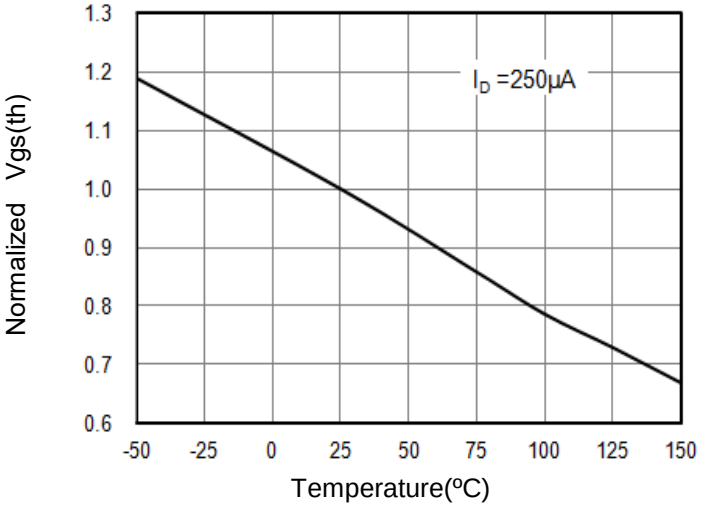


Figure 8: Vgs(th) vs. Junction Temperature

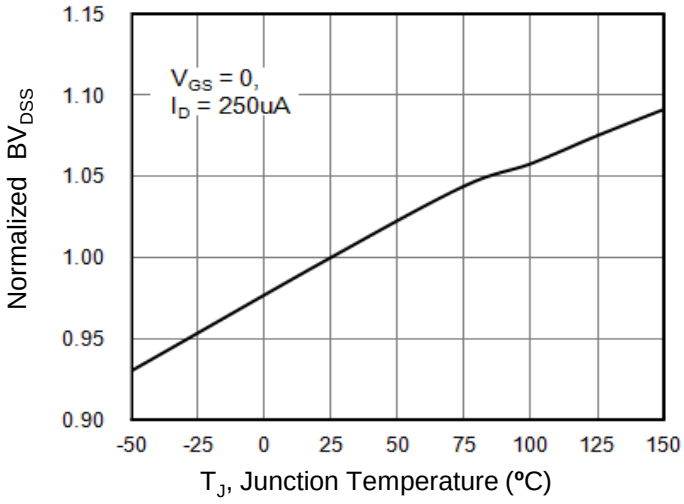


Figure 9: BV_{DSS} vs. Junction Temperature

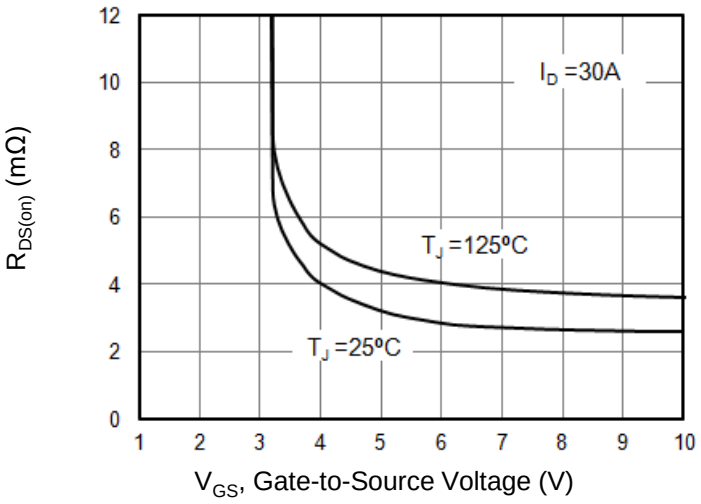


Figure 10: On-Resistance vs. Gate-Source Voltage

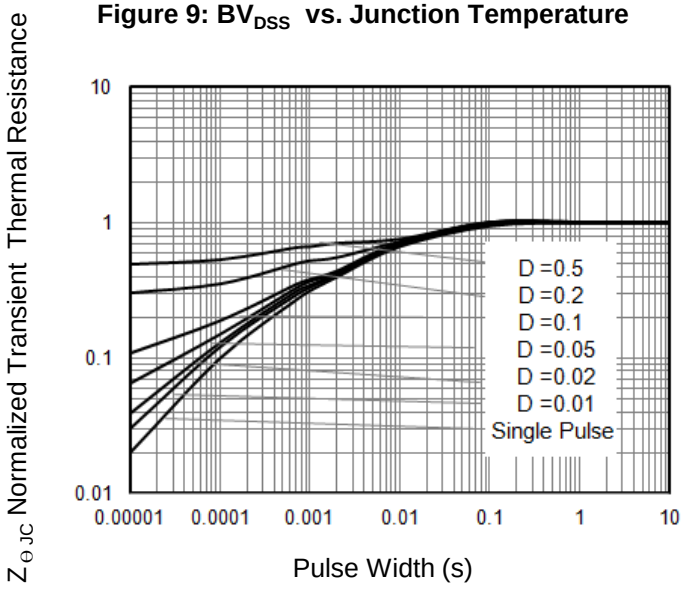


Figure 11: Normalized Transient Thermal Resistance

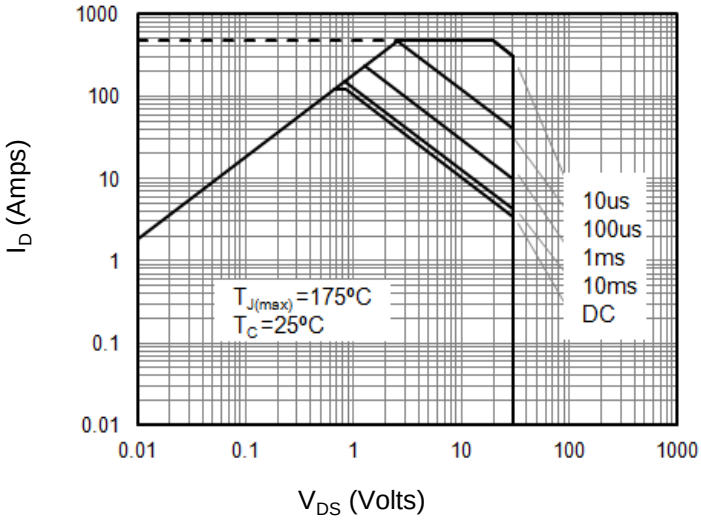


Figure 12: Safe Operating Area

Figure A：Gate Charge Test Circuit and Waveforms

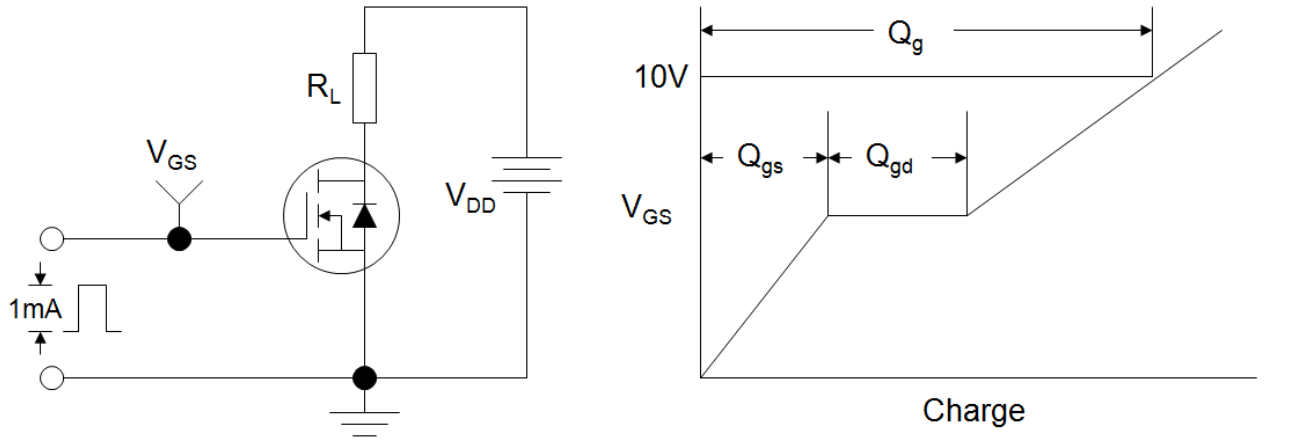


Figure B：Resistive Switching Test Circuit and Waveforms

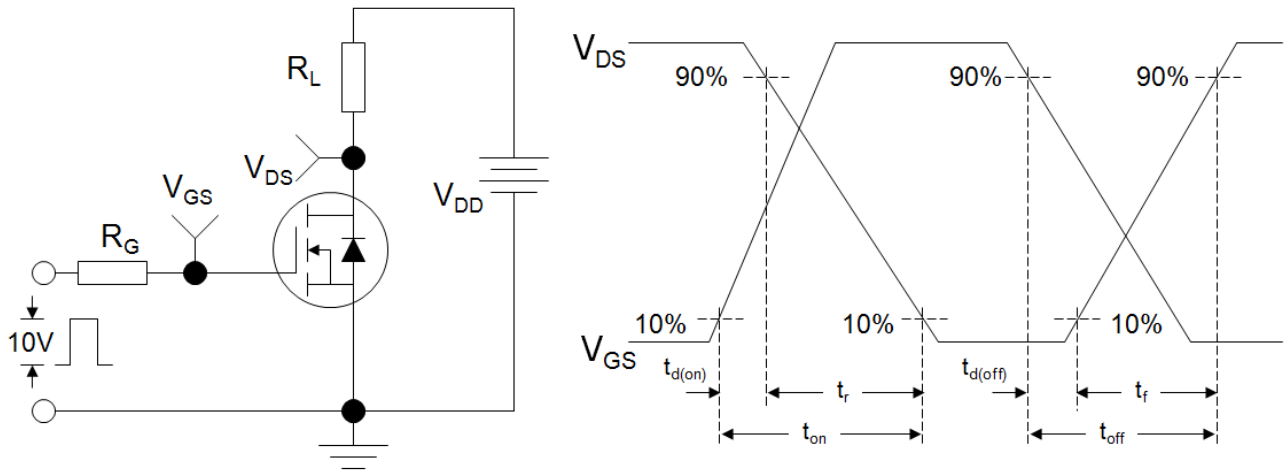
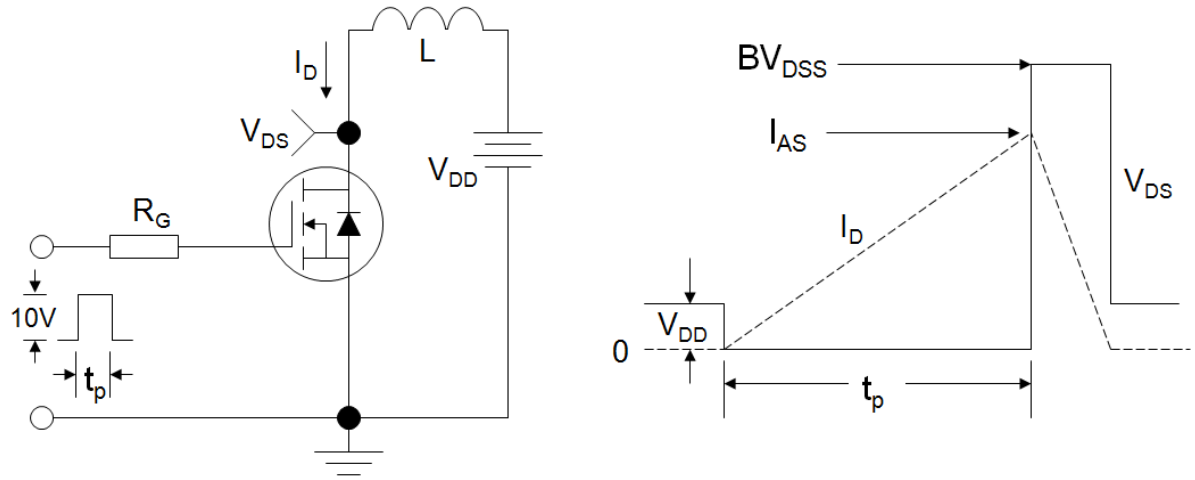


Figure C：Unclamped Inductive Switching (UIS) Test Circuit and Waveforms



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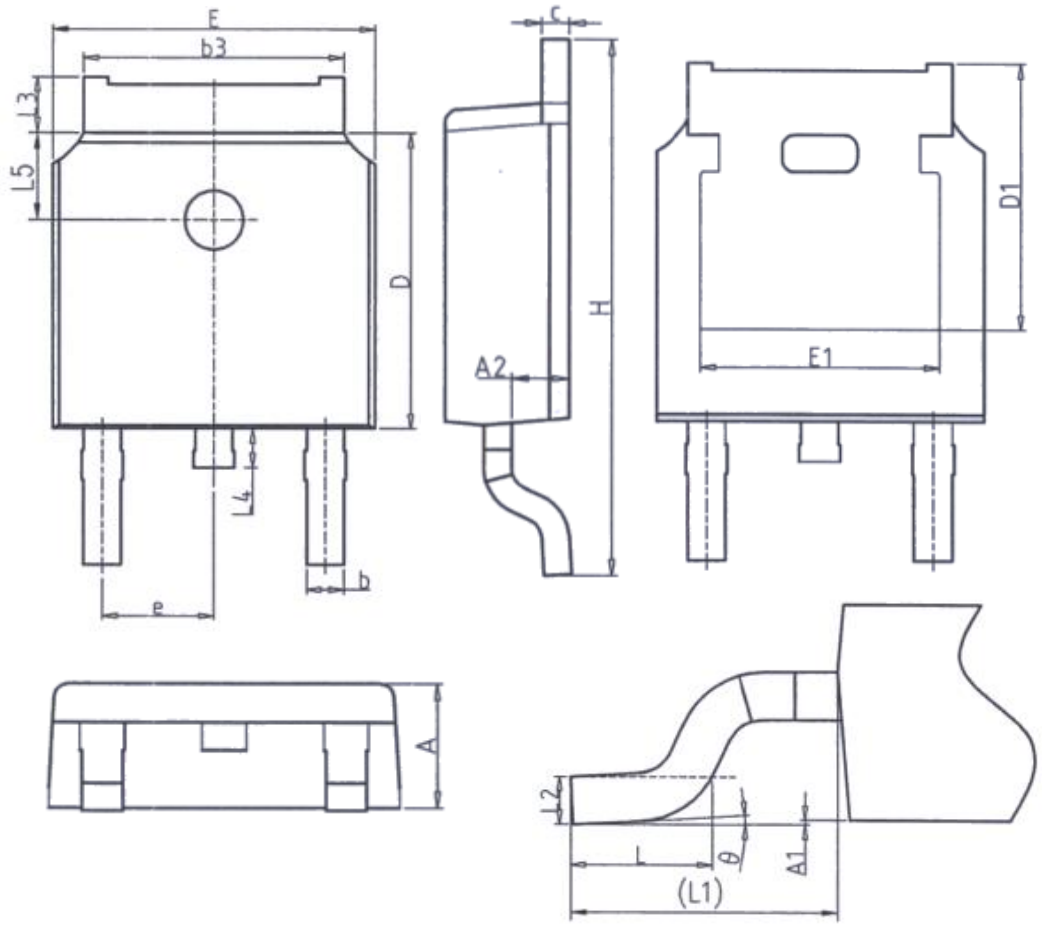

Unit: mm		
Symbol	Min.	Max.
A	2.20	2.40
A1	0.00	0.20
A2	0.97	1.17
b	0.68	0.90
b3	5.20	5.50
c	0.43	0.63
D	5.98	6.22
D1	5.30REF	
E	6.40	6.80
E1	4.63	–

Unit: mm		
Symbol	Min.	Max.
e	2.286BSC	
H	9.40	10.50
L	1.38	1.75
L1	2.90REF	
L2	0.51BSC	
L3	0.88	1.28
L4	–	1.00
L5	1.65	1.95
θ	0°	8°

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